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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/677,221	10/03/2003	Takashi Ohsako	2003-1364A	8585

513            7590            10/30/2007  
WENDEROTH, LIND & PONACK, L.L.P.  
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SUITE 800  
WASHINGTON, DC 20006-1021

EXAMINER
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GARCIA, JOANNIE A

ART UNIT	PAPER NUMBER
2823	

MAIL DATE	DELIVERY MODE
10/30/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

<b>Office Action Summary</b>	<b>Application No.</b>	<b>Applicant(s)</b>	
	10/677,221	OHSAKO ET AL.	
	<b>Examiner</b>	<b>Art Unit</b>	
	Joannie A. García	2823	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

#### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

#### Status

- 1) Responsive to communication(s) filed on 15 August 2007.
- 2a) This action is **FINAL**.                  2b) This action is non-final.
- 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

#### Disposition of Claims

- 4) Claim(s) 14-16 and 18-35 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) Claim(s) 18-23 is/are allowed.
- 6) Claim(s) 14-16 and 24-35 is/are rejected.
- 7) Claim(s) \_\_\_\_\_ is/are objected to.
- 8) Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

#### Application Papers

- 9) The specification is objected to by the Examiner.
- 10) The drawing(s) filed on \_\_\_\_\_ is/are: a) accepted or b) objected to by the Examiner.  
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

#### Priority under 35 U.S.C. § 119

- 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) All    b) Some \* c) None of:
1. Certified copies of the priority documents have been received.
  2. Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
  3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

\* See the attached detailed Office action for a list of the certified copies not received.

#### Attachment(s)

- |   |   |
|---|---|
| 1) <input type="checkbox"/> Notice of References Cited (PTO-892)  | 4) <input type="checkbox"/> Interview Summary (PTO-413)           |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)                        | Paper No(s)/Mail Date. _____.                                     |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO/SB/08)<br>Paper No(s)/Mail Date _____. | 5) <input type="checkbox"/> Notice of Informal Patent Application |
|   | 6) <input type="checkbox"/> Other: _____.                         |

The text of those sections of Title 35, U.S. Code not included in this action can be found in a prior Office action.

Claims 18-23 are rejected under 35 U.S.C. 103(a) as being unpatentable over Enomoto et al (US 2003/0032284 A1), in combination with the following comments.

The rejection is maintained as stated in the Office Action mailed 05-15-07, and as stated below.

Enomoto et al discloses a process for forming a gate electrode on a semiconductor substrate 1 having a tungsten silicide layer 13, a metallic polysilicon layer 7 under the tungsten silicide layer, and a SiN 15 on the tungsten silicide layer (Figures 3 and 4, and Paragraphs 0069, 0072, and 0073), a process of decreasing grain boundaries on a surface of the tungsten silicide layer at least a portion of which is exposed by performing a heat treatment in an atmosphere including ammonia after a reduced pressure process (Figure 8, and Paragraphs 0072, 0073, 0093, 0098, and 0134), and forming an oxide spacer 13/15 on a side wall of the gate electrode (Figures 3-4, and Paragraphs 0003, and 0071).

Enomoto et al discloses performing a heat treatment in an oxidizable gas on the metallic silicide layer (Paragraph 0073). Enomoto et al discloses the claimed invention except for including ammonia in a range of 1% to 3%, performing said heat treatment in an oxidizable atmosphere of less than 100 ppm, and performing said heat treatment at a temperature of 700 °C to 800 °C for a time of 30 sec to 40 sec at a pressure of 13 to 65 Pa. It would have been obvious to one having ordinary skill in the art at the time the invention was made to determine a suitable amount of the oxidizable atmosphere, and a suitable time, temperature and pressure, since it has

been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233.

Applicant argues that Enomoto et al does not teach forming a gate electrode on a semiconductor substrate, in which the electrode has a tungsten silicide layer, a metallic polysilicon layer under the tungsten silicide layer, and a SiN layer on the tungsten silicide layer. However, Enomoto et al discloses forming the gate electrode on the semiconductor substrate 1, in which the electrode has the tungsten silicide layer 13, a metallic polysilicon layer 7 under the tungsten silicide layer, and the SiN layer 15 on the tungsten silicide layer, as shown in Figure 4, and as disclosed in Paragraphs 0069, 0072, and 0073.

Claims 14-16, and 24-35, are allowed.

**THIS ACTION IS MADE FINAL.** Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event,

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however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Joannie García whose telephone number is (571) 272-1861. The examiner can normally be reached on Monday through Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Matthew Smith, can be reached on (571) 272-1907. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

/George Fourson/  
George Fourson, Art Unit 2823

/JAG/  
October 23, 2007

GFourson  
Primary Examiner